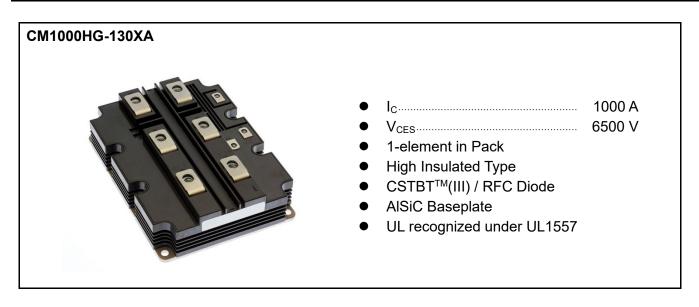


<High Voltage Insulated Gate Bipolar Transistor: HVIGBT >

CM1000HG-130XA

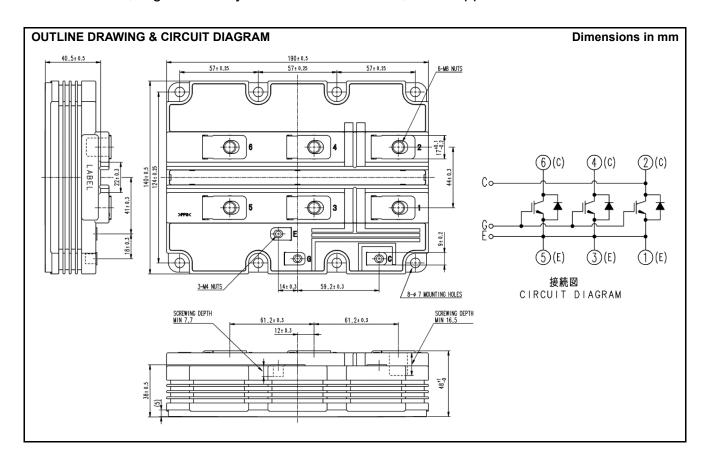
HIGH POWER SWITHCHING USE INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules



APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers



CM1000HG-130XA HIGH POWER SWITHCHING USE INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

MAXIMUM RATINGS

Symbol	Item	Conditions	Ratings	Unit
		$V_{GE} = 0V, T_j = 150^{\circ}C$	6500	
V_{CES}	Collector-emitter voltage	$V_{GE} = 0V, T_j = 25^{\circ}C$	6300	V
		$V_{CE} = 0V, T_j = -50^{\circ}C$	5700	
V_{GES}	Gate-emitter voltage	$V_{CE} = 0V, T_j = 25^{\circ}C$	± 20	٧
Ic	Collector current	DC, T _C = 111°C	1000	Α
I _{CRM}	Collector current	Pulse (Note 1)	2000	Α
IE	Fitter comment	DC, T _C = 95°C	1000	Α
I _{ERM}	Emitter current (Note 2)	Pulse (Note 1)	2000	Α
P _{tot}	Maximum power dissipation (Note 3)	T _c = 25°C, IGBT part	12500	W
V_{iso}	Isolation voltage	RMS, sinusoidal, f = 60Hz, t = 1min.	10200	V
Q _{PD}	Partial discharge	RMS, sinusoidal, f = 60Hz, V1 = 6900 V, V2 = 5100 V	10	pC
T _i	Junction temperature	_	−50 ~ +150	°C
T _{jop}	Operating junction temperature	_	−50 ~ +150	°C
T _{stg}	Storage temperature	_	−55 ~ +150	°C
t _{psc}	Short circuit pulse width	$V_{CC} \le 4500V, V_{GE} = \pm 15V,$ $R_{G(on)} = 4.3\Omega, R_{G(off)} = 39\Omega, Tj = 150^{\circ}C$	10	μs

ELECTRICAL CHARACTERISTICS

Symbol	Item	Conditions			Unit		
Symbol				Min	Тур	Max	Unit
I _{CES}			T _j = 25°C	_		5.0	
	Collector cutoff current	$V_{CE} = V_{CES}, V_{GE} = 0V$	T _i = 125°C	_	5.0	_	mA
			T _j = 150°C	_	_	150.0	
V _{GE(th)}	Gate-emitter threshold voltage	V _{CE} = 10V, I _C =100mA, T _j = 25°C		6.50	7.00	7.50	V
I _{GES}	Gate leakage current			-0.5	_	0.5	μA
Cies	Input capacitance	\\ -40\\\\ -0\\frac{1}{5} -400\\\		_	152	1	nF
C _{oes}	Output capacitance	$V_{CE} = 10V, V_{GE} = 0V, f = 100kHz$		_	6.2	ı	nF
C _{res}	Reverse transfer capacitance	T _j = 25°C		_	0.8		nF
Q_G	Total gate charge	$V_{CC} = 3600V$, $I_{C} = 1000A$, $V_{GE} = \pm 15V$	/	_	9.9	1	μC
		I _C =1000A (Note 4)	T _j = 25°C	-	2.60	l	
V_{CEsat}	Collector-emitter saturation voltage	$V_{GE} = 1000A^{(vision)}$	T _j = 125°C	_	3.25	ı	V
		VGE - 13V	T _j = 150°C	_	3.40	3.90	
t _{d(on)}	Turn-on delay time		T _j = 150°C	-	1	1.20	μs
t _r	Rise time	V _{CC} = 3600V	$T_{j} = 150^{\circ}C$	_	1	070	μs
	Turn-on switching energy (per pulse) (Note 5)	$V_{GE} = \pm 15V$ $R_{G(on)} = 4.3\Omega$ $L_s = 150 nH$ Inductive load	T _i = 25°C	_	10.50	1	
E _{on(10%)}			T _j = 125°C	_	10.50	_	J
			T _j = 150°C	_	10.50	_	
	Turn-on switching energy (per pulse) (Note 6)		T _j = 25°C	_	11.00	_	J
Eon			T _j = 125°C	_	11.00		
			T _j = 150°C	_	11.40	_	
			T _i = 25°C	_	7.40	1	
$t_{\text{d(off)}}$	Turn-off delay time		T _j = 125°C	-	7.70	l	μs
			T _j = 150°C	_	8.00		
		V _{CC} = 3600V	T _j = 25°C	_	0.50	1	
t_f	Fall time	I _C = 1000A	T _j = 125°C	_	0.60	_	μs
		V _{GE} = ±15V	T _i = 150°C	_	0.65	_	
E _{off(10%)}	Turn-off switching energy	$R_{G(off)} = 39\Omega$	T _j = 25°C	_	5.50		
		L = 150 nH	T _j = 125°C	_	7.10	ı	J
	(per pulse) (Note 5)	Inductive load	T _j = 150°C	_	7.50	ı	
	T (6) 1 1 1	1	T _i = 25°C	_	5.90	ı	
E_{off}	Turn-off switching energy		T _i = 125°C	_	7.50	_	J
└ off	(per pulse) (Note 6)	T _i = 15		_	8.00	_	

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

ELECTRICAL CHARACTERISTICS

Cumbal	Item		Conditions		Limits			Unit
Symbol	item		Conditions		Min	Тур	Max	Offic
			I _E = 1000A (Note 4)	T _j = 25°C		2.40		
V_{EC}	Emitter-collector voltage	(Note 2)	$V_{GE} = 0V$	T _j = 125°C	_	2.80	_	V
			VGE - UV	T _i = 150°C	_	2.90	3.40	
				$T_j = 25^{\circ}C$	_	2.70	_	
t _{rr}	Reverse recovery time	(Note 2)		$T_{j} = 125^{\circ}C$	_	3.30	_	μs
				$T_{j} = 150^{\circ}C$		3.50	_	
				$T_j = 25^{\circ}C$	_	1130	_	
Irr	Reverse recovery current	(Note 2)		$T_j = 125^{\circ}C$	_	1100	_	Α
			$T_{i} = 150^{\circ}C$	_	1100	_		
			V _{CC} = 3600V	$T_j = 25^{\circ}C$	_	2200	_	
Q _{rr(10%)}	Reverse recovery charge	(Note 2, 7)	I _C = 1000A	$T_j = 125^{\circ}C$		2750	_	μC
			$V_{GE} = \pm 15V$	$T_{j} = 150^{\circ}C$	_	3000	_	
			$R_{G(on)} = 4.3\Omega$	$T_i = 25^{\circ}C$	_	2250	_	
Q_{rr}	Reverse recovery charge	(Note 2, 6)		$T_j = 125^{\circ}C$		2800	_	μC
		go	Inductive load	T _j = 150°C	_	3100	_	μ
				T _i = 25°C	_	3.40	_	
E _{rec(10%)}	Reverse recovery energy	(Note 2, 5)		T _i = 125°C		4.90	_	J
	(per pulse) (Note 2, 5)	1	T _j = 150°C		5.50	_		
			T _j = 25°C		3.60	_		
E _{rec}	Reverse recovery energy	(Note 2, 6)		T _j = 125°C	_	5.10	_	J
	(per pulse)	(T _j = 150°C	_	5.80		

THERMAL CHARACTERISTICS

0	Item	Conditions		Limits				
Symbol				Тур	Max	Unit		
R _{th(j-c)Q}	The amount in a sintance	Junction to Case, IGBT part	_	_	10.0	K/kW		
R _{th(j-c)D}	Thermal resistance	Junction to Case, FWDi part	_	_	16.0	K/kW		
R _{th(c-s)}	Contact thermal resistance	Case to heat sink, λ _{grease} = 1W/m k, D _(c-s) = 80μm	_	5.0	_	K/kW		

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions		Linit		
			Min	Тур	Max	Unit
M_t		M8 : Main terminals screw	7.0	_	19.0	N·m
Ms	Mounting torque	M6 : Mounting screw	3.0	_	6.0	N·m
Mt		M4 : Auxiliary terminals screw	1.0	_	3.0	N⋅m
m	Mass			1.5	_	kg
CTI	Comparative tracking index		600	_	_	_
da	Clearance		26.0	_	_	mm
ds	Creepage distance		56.0	_	_	mm
L _{P CE}	Parasitic stray inductance		_	13.5	_	nΗ
R _{CC'+EE'}	Internal lead resistance	T _C = 25°C	_	0.12	_	mΩ

Note1. Pulse width and repetition rate should be such that junction temperature (T_j) does not exceed T_{jopmax} rating.

Note2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD_i).

Note3. Junction temperature (T_j) should not exceed T_{jmax} rating (150°C).

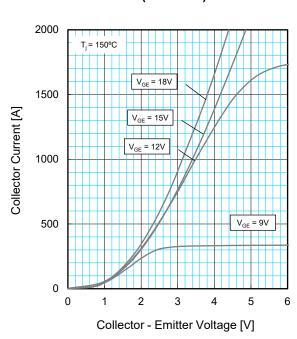
Note4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

Note5. The integration range of switching energies is from $10\%V_{CE}$ to $10\%I_{C}(10\%I_{E})$.

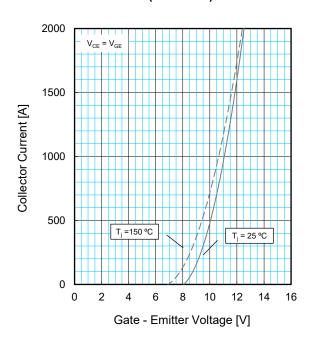
Note6. Definition of all items is according to IEC 60747, unless otherwise specified.

Note7. The integration range of reverse recovery charge is from $I_E = 0A$ to $10\%I_E$.

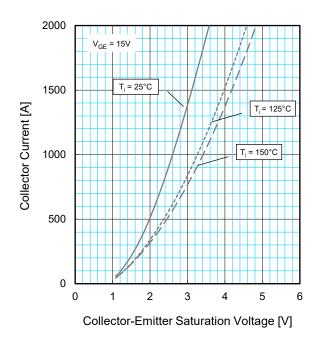
OUTPUT CHARACTERISTICS (TYPICAL)



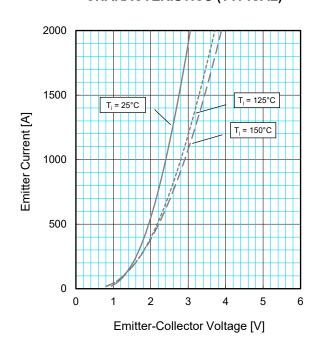
TRANSFER CHARACTERISTICS (TYPICAL)



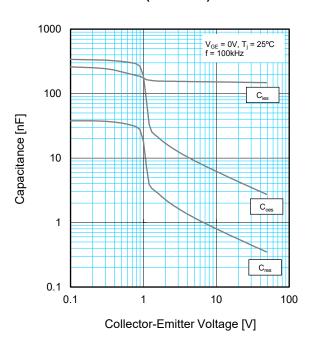
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



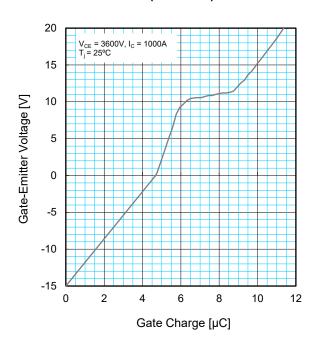
FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)



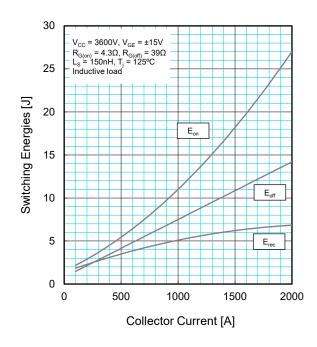
CAPACITANCE CHARACTERISTICS (TYPICAL)



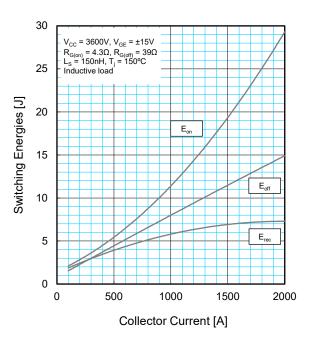
GATE CHARGE CHARACTERISTICS (TYPICAL)



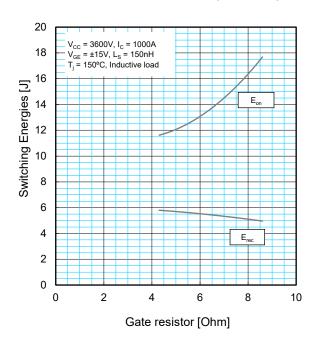
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



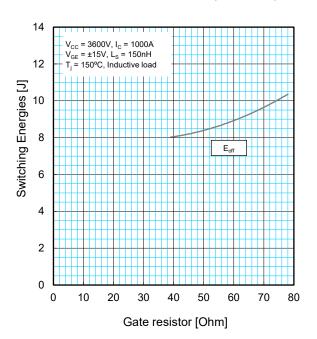
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



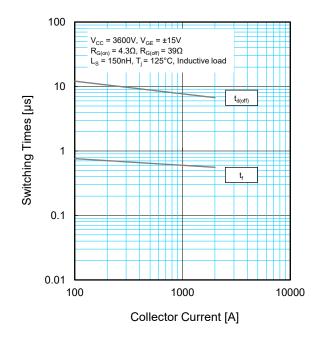
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



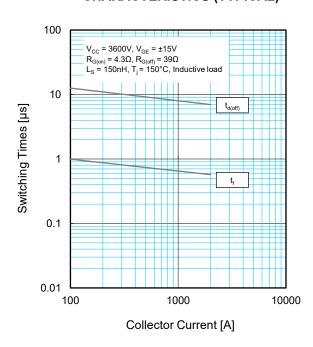
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



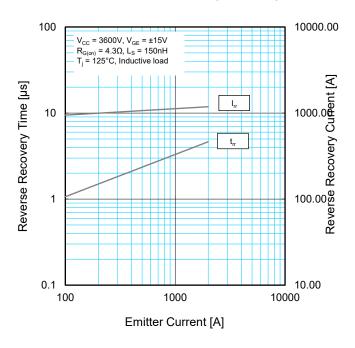
HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



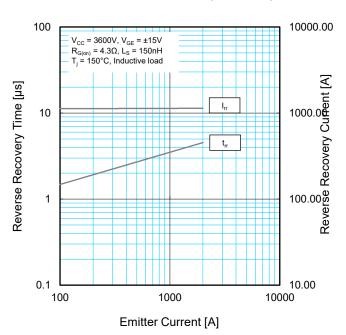
HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



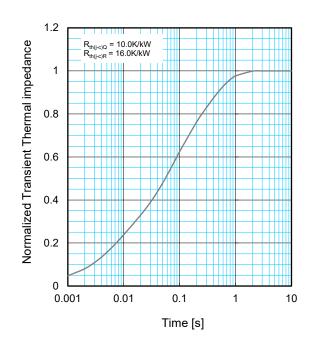
FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



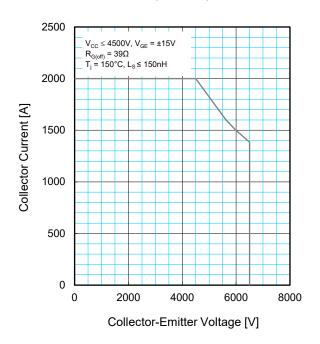
TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



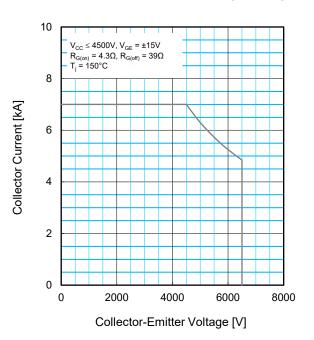
$$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_{i} \left\{ 1 - \exp\left(-\frac{t}{\tau_{i}}\right) \right\}$$

	1	2	3	4
R _i / R _{th(j-c)}	0.0096	0.1893	0.4044	0.3967
τ _i [sec]	0.0001	0.0058	0.0602	0.3512

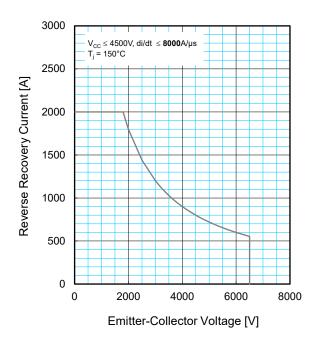
REVERSE BIAS SAFE OPERATING AREA (RBSOA)



SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)



FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)





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